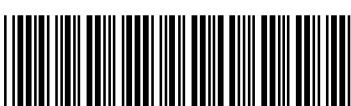


Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10710600	FUJISAKI, IWAO
	Examiner	Art Unit
	DAVID Q NGUYEN	2617

SEARCHED

Class	Subclass	Date	Examiner
455	556.1	04/21/09	DN
370	338	04/21/09	DN
455	456.1	08/12/09	DN
705	26	08/12/09	DN
340	426.1	08/12/09	DN

SEARCH NOTES

Search Notes	Date	Examiner
Text search	04/21/09	DN
Text search	08/12/09	DN

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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